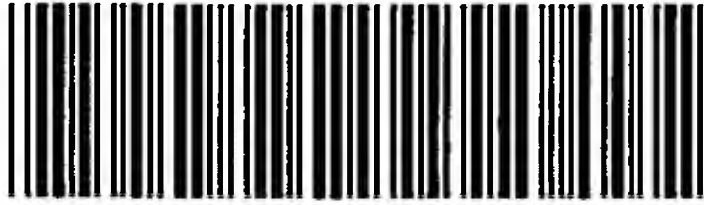


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,839	BEENAU ET AL.	
	Examiner	Art Unit	
	Daniel I. Walsh	2876	

SEARCHED			
Class	Subclass	Date	Examiner
235	379, 380, 382, 435, 487	6/20/2005	DW
705	18,43,45	6/20/2005	DW
340	5.51-.53	6/20/2005	DW
713	200,202	6/20/2005	DW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search attached	6/20/2005	DW